

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10572818	BICHOT ET AL.
Examiner	Art Unit	
ZEWDU BEYEN	2419	

SEARCHED

Class	Subclass	Date	Examiner
370	all with keyterms	20081008	zb
370	390,310,312,341	20081008	zb
370	390,256,218	20090424	zb

SEARCH NOTES

Search Notes	Date	Examiner
I did inventor search using EAST and eDAN. Regarding claims 1,6,13, and 18 i discussed with Abelson Ronald	20081008	zb
keyterms I used:multicast ,point to multipoint, unicast, point to point ,listen, monitor, active , for more see attached search stratagy	20081008	zb
database used (USPGPUB,USPAT,FPRS,EPO,JPO,DERWENT,IBM_TDB)...SEE SEARCH PRINTOUT	20090424	zb

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner